

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/448,606	BONICEL, JEAN-PIERRE	
Examiner		Art Unit		Page 1 of 1
Chau N Nguyen		2831		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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	P					
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**NON-PATENT DOCUMENTS**

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